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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

| Details | |
|--------------------------------|--|
| Product Status | Obsolete |
| Number of LABs/CLBs | - |
| Number of Logic Elements/Cells | - |
| Total RAM Bits | 110592 |
| Number of I/O | 95 |
| Number of Gates | 600000 |
| Voltage - Supply | 1.425V ~ 1.575V |
| Mounting Type | Surface Mount |
| Operating Temperature | 0°C ~ 85°C (TJ) |
| Package / Case | 208-BFQFP |
| Supplier Device Package | 208-PQFP (28x28) |
| Purchase URL | https://www.e-xfl.com/product-detail/microsemi/afs600-pqg208 |
| | |

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Fusion Device Architecture Overview



Figure 1 • Fusion Device Architecture Overview (AFS600)

Package I/Os: Single-/Double-Ended (Analog)

| Fusion Devices | AFS090 | AFS250 | AFS600 | AFS1500 |
|-----------------------|------------|-----------------------|-----------------------|------------------------|
| ARM Cortex-M1 Devices | | M1AFS250 | M1AFS600 | M1AFS1500 |
| Pigeon Point Devices | | | P1AFS600 ¹ | P1AFS1500 ¹ |
| MicroBlade Devices | | U1AFS250 ² | U1AFS600 ² | U1AFS1500 ² |
| QN108 ³ | 37/9 (16) | | | |
| QN180 ³ | 60/16 (20) | 65/15 (24) | | |
| PQ208 ⁴ | | 93/26 (24) | 95/46 (40) | |
| FG256 | 75/22 (20) | 114/37 (24) | 119/58 (40) | 119/58 (40) |
| FG484 | | | 172/86 (40) | 223/109 (40) |
| FG676 | | | | 252/126 (40) |
| Notes: | • | 1 | | • |

1. Pigeon Point devices are only offered in FG484 and FG256.

2. MicroBlade devices are only offered in FG256.

3. Package not available.

4. Fusion devices in the same package are pin compatible with the exception of the PQ208 package (AFS250 and AFS600).

Advanced Architecture

The proprietary Fusion architecture provides granularity comparable to standard-cell ASICs. The Fusion device consists of several distinct and programmable architectural features, including the following (Figure 1-1 on page 1-5):

- Embedded memories
 - Flash memory blocks
 - FlashROM
 - SRAM and FIFO
- Clocking resources
 - PLL and CCC
 - RC oscillator
 - Crystal oscillator
 - No-Glitch MUX (NGMUX)
- Digital I/Os with advanced I/O standards
- FPGA VersaTiles
- Analog components
 - ADC
 - Analog I/Os supporting voltage, current, and temperature monitoring
 - 1.5 V on-board voltage regulator
 - Real-time counter

The FPGA core consists of a sea of VersaTiles. Each VersaTile can be configured as a three-input logic lookup table (LUT) equivalent or a D-flip-flop or latch (with or without enable) by programming the appropriate flash switch interconnections. This versatility allows efficient use of the FPGA fabric. The VersaTile capability is unique to the Microsemi families of flash-based FPGAs. VersaTiles and larger functions are connected with any of the four levels of routing hierarchy. Flash switches are distributed throughout the device to provide nonvolatile, reconfigurable interconnect programming. Maximum core utilization is possible for virtually any design.

In addition, extensive on-chip programming circuitry allows for rapid (3.3 V) single-voltage programming of Fusion devices via an IEEE 1532 JTAG interface.

Unprecedented Integration

Integrated Analog Blocks and Analog I/Os

Fusion devices offer robust and flexible analog mixed signal capability in addition to the highperformance flash FPGA fabric and flash memory block. The many built-in analog peripherals include a configurable 32:1 input analog MUX, up to 10 independent MOSFET gate driver outputs, and a configurable ADC. The ADC supports 8-, 10-, and 12-bit modes of operation with a cumulative sample rate up to 600 k samples per second (Ksps), differential nonlinearity (DNL) < 1.0 LSB, and Total Unadjusted Error (TUE) of 0.72 LSB in 10-bit mode. The TUE is used for characterization of the conversion error and includes errors from all sources, such as offset and linearity. Internal bandgap circuitry offers 1% voltage reference accuracy with the flexibility of utilizing an external reference voltage. The ADC channel sampling sequence and sampling rate are programmable and implemented in the FPGA logic using Designer and Libero SoC software tool support.

Two channels of the 32-channel ADCMUX are dedicated. Channel 0 is connected internally to VCC and can be used to monitor core power supply. Channel 31 is connected to an internal temperature diode which can be used to monitor device temperature. The 30 remaining channels can be connected to external analog signals. The exact number of I/Os available for external connection signals is device-dependent (refer to the "Fusion Family" table on page I for details).

Global Clocking

Fusion devices have extensive support for multiple clocking domains. In addition to the CCC and PLL support described above, there are on-chip oscillators as well as a comprehensive global clock distribution network.

The integrated RC oscillator generates a 100 MHz clock. It is used internally to provide a known clock source to the flash memory read and write control. It can also be used as a source for the PLLs.

The crystal oscillator supports the following operating modes:

- Crystal (32.768 KHz to 20 MHz)
- Ceramic (500 KHz to 8 MHz)
- RC (32.768 KHz to 4 MHz)

Each VersaTile input and output port has access to nine VersaNets: six main and three quadrant global networks. The VersaNets can be driven by the CCC or directly accessed from the core via MUXes. The VersaNets can be used to distribute low-skew clock signals or for rapid distribution of high-fanout nets.

Digital I/Os with Advanced I/O Standards

The Fusion family of FPGAs features a flexible digital I/O structure, supporting a range of voltages (1.5 V, 1.8 V, 2.5 V, and 3.3 V). Fusion FPGAs support many different digital I/O standards, both single-ended and differential.

The I/Os are organized into banks, with four or five banks per device. The configuration of these banks determines the I/O standards supported. The banks along the east and west sides of the device support the full range of I/O standards (single-ended and differential). The south bank supports the Analog Quads (analog I/O). In the family's two smaller devices, the north bank supports multiple single-ended digital I/O standards. In the family's larger devices, the north bank is divided into two banks of digital Pro I/Os, supporting a wide variety of single-ended, differential, and voltage-referenced I/O standards.

Each I/O module contains several input, output, and enable registers. These registers allow the implementation of the following applications:

- Single-Data-Rate (SDR) applications
- Double-Data-Rate (DDR) applications—DDR LVDS I/O for chip-to-chip communications
- Fusion banks support LVPECL, LVDS, BLVDS, and M-LVDS with 20 multi-drop points.

VersaTiles

The Fusion core consists of VersaTiles, which are also used in the successful ProASIC3 family. The Fusion VersaTile supports the following:

- All 3-input logic functions—LUT-3 equivalent
- Latch with clear or set
- D-flip-flop with clear or set and optional enable

Refer to Figure 1-2 for the VersaTile configuration arrangement.







Figure 2-6 • Sequential Timing Model and Waveforms

Sequential Timing Characteristics

Table 2-2 • Register Delays
Commercial Temperature Range Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

| Parameter | Description | -2 | -1 | Std. | Units |
|---------------------|---|------|------|------|-------|
| t _{CLKQ} | Clock-to-Q of the Core Register | 0.55 | 0.63 | 0.74 | ns |
| t _{SUD} | Data Setup Time for the Core Register | 0.43 | 0.49 | 0.57 | ns |
| t _{HD} | Data Hold Time for the Core Register | 0.00 | 0.00 | 0.00 | ns |
| t _{SUE} | Enable Setup Time for the Core Register | 0.45 | 0.52 | 0.61 | ns |
| t _{HE} | Enable Hold Time for the Core Register | 0.00 | 0.00 | 0.00 | ns |
| t _{CLR2Q} | Asynchronous Clear-to-Q of the Core Register | 0.40 | 0.45 | 0.53 | ns |
| t _{PRE2Q} | Asynchronous Preset-to-Q of the Core Register | 0.40 | 0.45 | 0.53 | ns |
| t _{REMCLR} | Asynchronous Clear Removal Time for the Core Register | 0.00 | 0.00 | 0.00 | ns |
| t _{RECCLR} | Asynchronous Clear Recovery Time for the Core Register | 0.22 | 0.25 | 0.30 | ns |
| t _{REMPRE} | Asynchronous Preset Removal Time for the Core Register | 0.00 | 0.00 | 0.00 | ns |
| t _{RECPRE} | Asynchronous Preset Recovery Time for the Core Register | 0.22 | 0.25 | 0.30 | ns |
| t _{WCLR} | Asynchronous Clear Minimum Pulse Width for the Core Register | 0.22 | 0.25 | 0.30 | ns |
| t _{WPRE} | Asynchronous Preset Minimum Pulse Width for the Core Register | 0.22 | 0.25 | 0.30 | ns |
| t _{CKMPWH} | Clock Minimum Pulse Width High for the Core Register | 0.32 | 0.37 | 0.43 | ns |
| t _{CKMPWL} | Clock Minimum Pulse Width Low for the Core Register | 0.36 | 0.41 | 0.48 | ns |

Note: For the derating values at specific junction temperature and voltage supply levels, refer to Table 3-7 on page 3-9.



Global Resources (VersaNets)

Fusion devices offer powerful and flexible control of circuit timing through the use of analog circuitry. Each chip has six CCCs. The west CCC also contains a PLL core. In the two larger devices (AFS600 and AFS1500), the west and the east CCCs each contain a PLL. The PLLs include delay lines, a phase shifter (0°, 90°, 180°, 270°), and clock multipliers/dividers. Each CCC has all the circuitry needed for the selection and interconnection of inputs to the VersaNet global network. The east and west CCCs each have access to three VersaNet global lines on each side of the chip (six lines total). The CCCs at the four corners each have access to three quadrant global lines on each quadrant of the chip.

Advantages of the VersaNet Approach

One of the architectural benefits of Fusion is the set of powerful and low-delay VersaNet global networks. Fusion offers six chip (main) global networks that are distributed from the center of the FPGA array (Figure 2-11). In addition, Fusion devices have three regional globals (quadrant globals) in each of the four chip quadrants. Each core VersaTile has access to nine global networks on the device. Each of these networks contains spines and ribs that reach all VersaTiles in all quadrants (Figure 2-12 on page 2-12). This flexible VersaNet global network architecture allows users to map up to 180 different internal/external clocks in a Fusion device. Details on the VersaNet networks are given in Table 2-4 on page 2-12. The flexibility of the Fusion VersaNet global network allows the designer to address several design requirements. User applications that are clock-resource-intensive can easily route external or gated internal clocks using VersaNet global routing networks. Designers can also drastically reduce delay penalties and minimize resource usage by mapping critical, high-fanout nets to the VersaNet global network.



Figure 2-11 • Overview of Fusion VersaNet Global Network

Crystal Oscillator

The Crystal Oscillator (XTLOSC) is source that generates the clock from an external crystal. The output of XTLOSC CLKOUT signal can be selected as an input to the PLL. Refer to the "Clock Conditioning Circuits" section for more details. The XTLOSC can operate in normal operations and Standby mode (RTC is running and 1.5 V is not present).

In normal operation, the internal FPGA_EN signal is '1' as long as 1.5 V is present for VCC. As such, the internal enable signal, XTL_EN, for Crystal Oscillator is enabled since FPGA_EN is asserted. The XTL_MODE has the option of using MODE or RTC_MODE, depending on SELMODE.

During Standby, 1.5 V is not available, as such, and FPGA_EN is '0'. SELMODE must be asserted in order for XTL_EN to be enabled; hence XTL_MODE relies on RTC_MODE. SELMODE and RTC_MODE must be connected to RTCXTLSEL and RTCXTLMODE from the AB respectively for correct operation during Standby (refer to the "Real-Time Counter System" section on page 2-31 for a detailed description).

The Crystal Oscillator can be configured in one of four modes:

- RC network, 32 KHz to 4 MHz
- Low gain, 32 to 200 KHz
- Medium gain, 0.20 to 2.0 MHz
- High gain, 2.0 to 20.0 MHz

In RC network mode, the XTAL1 pin is connected to an RC circuit, as shown in Figure 2-16 on page 2-18. The XTAL2 pin should be left floating. The RC value can be chosen based on Figure 2-18 for any desired frequency between 32 KHz and 4 MHz. The RC network mode can also accommodate an external clock source on XTAL1 instead of an RC circuit.

In Low gain, Medium gain, and High gain, an external crystal component or ceramic resonator can be added onto XTAL1 and XTAL2, as shown in Figure 2-16 on page 2-18. In the case where the Crystal Oscillator block is not used, the XTAL1 pin should be connected to GND and the XTAL2 pin should be left floating.



Note: *Internal signal—does not exist in macro.

Figure 2-17 • XTLOSC Macro

Clock Conditioning Circuits

In Fusion devices, the CCCs are used to implement frequency division, frequency multiplication, phase shifting, and delay operations.

The CCCs are available in six chip locations—each of the four chip corners and the middle of the east and west chip sides.

Each CCC can implement up to three independent global buffers (with or without programmable delay), or a PLL function (programmable frequency division/multiplication, phase shift, and delays) with up to three global outputs. Unused global outputs of a PLL can be used to implement independent global buffers, up to a maximum of three global outputs for a given CCC.

A global buffer can be placed in any of the three global locations (CLKA-GLA, CLKB-GLB, and CLKC-GLC) of a given CCC.

A PLL macro uses the CLKA CCC input to drive its reference clock. It uses the GLA and, optionally, the GLB and GLC global outputs to drive the global networks. A PLL macro can also drive the YB and YC regular core outputs. The GLB (or GLC) global output cannot be reused if the YB (or YC) output is used (Figure 2-19). Refer to the "PLL Macro" section on page 2-27 for more information.

Each global buffer, as well as the PLL reference clock, can be driven from one of the following:

- · 3 dedicated single-ended I/Os using a hardwired connection
- 2 dedicated differential I/Os using a hardwired connection
- The FPGA core

The CCC block is fully configurable, either via flash configuration bits set in the programming bitstream or through an asynchronous interface. This asynchronous interface is dynamically accessible from inside the Fusion device to permit changes of parameters (such as divide ratios) during device operation. To increase the versatility and flexibility of the clock conditioning system, the CCC configuration is determined either by the user during the design process, with configuration data being stored in flash memory as part of the device programming procedure, or by writing data into a dedicated shift register during normal device operation. This latter mode allows the user to dynamically reconfigure the CCC without the need for core programming. The shift register is accessed through a simple serial interface. Refer to the "UJTAG Applications in Microsemi's Low-Power Flash Devices" chapter of the *Fusion FPGA Fabric User Guide* and the "CCC and PLL Characteristics" section on page 2-28 for more information.



RAM512X18 Description

Figure 2-49 • RAM512X18

Temperature Monitor

The final pin in the Analog Quad is the Analog Temperature (AT) pin. The AT pin is used to implement an accurate temperature monitor in conjunction with an external diode-connected bipolar transistor (Figure 2-76). For improved temperature measurement accuracy, it is important to use the ATRTN pin for the return path of the current sourced by the AT pin. Each ATRTN pin is shared between two adjacent Analog Quads. Additionally, if not used for temperature monitoring, the AT pin can provide functionality similar to that of the AV pad. However, in this mode only positive voltages can be applied to the AT pin, and only two prescaler factors are available (16 V and 4 V ranges—refer to Table 2-57 on page 2-130).



Figure 2-76 • Temperature Monitor Quad

Analog-to-Digital Converter Block

At the heart of the Fusion analog system is a programmable Successive Approximation Register (SAR) ADC. The ADC can support 8-, 10-, or 12-bit modes of operation. In 12-bit mode, the ADC can resolve 500 ksps. All results are MSB-justified in the ADC. The input to the ADC is a large 32:1 analog input multiplexer. A simplified block diagram of the Analog Quads, analog input multiplexer, and ADC is shown in Figure 2-79. The ADC offers multiple self-calibrating modes to ensure consistent high performance both at power-up and during runtime.



Figure 2-79 • ADC Block Diagram



Device Architecture

ADC Description

The Fusion ADC is a 12-bit SAR ADC. It offers a wide variety of features for different use models. Figure 2-80 shows a block diagram of the Fusion ADC.

- · Configurable resolution: 8-bit, 10-bit, and 12-bit mode
- DNL: 0.6 LSB for 10-bit mode
- INL: 0.4 LSB for 10-bit mode
- No missing code
- Internal VAREF = 2.56 V
- Maximum Sample Rate = 600 Ksps
- Power-up calibration and dynamic calibration after every sample to compensate for temperature drift over time



Figure 2-80 • ADC Simplified Block Diagram

ADC Theory of Operation

An analog-to-digital converter is used to capture discrete samples of a continuous analog voltage and provide a discrete binary representation of the signal. Analog-to-digital converters are generally characterized in three ways:

- Input voltage range
- Resolution
- Bandwidth or conversion rate

The input voltage range of an ADC is determined by its reference voltage (VREF). Fusion devices include an internal 2.56 V reference, or the user can supply an external reference of up to 3.3 V. The following examples use the internal 2.56 V reference, so the full-scale input range of the ADC is 0 to 2.56 V.

The resolution (LSB) of the ADC is a function of the number of binary bits in the converter. The ADC approximates the value of the input voltage using 2n steps, where n is the number of bits in the converter. Each step therefore represents VREF÷ 2n volts. In the case of the Fusion ADC configured for 12-bit operation, the LSB is 2.56 V / 4096 = 0.625 mV.

Finally, bandwidth is an indication of the maximum number of conversions the ADC can perform each second. The bandwidth of an ADC is constrained by its architecture and several key performance characteristics.

Table 2-49 • Analog Channel Specifications (continued)Commercial Temperature Range Conditions, TJ = 85°C (unless noted otherwise),Typical: VCC33A = 3.3 V, VCC = 1.5 V

| Parameter | Description | Condition | Min. | Тур. | Max. | Units | | | | | |
|--|--------------------------------|---|------|------|------|-------|--|--|--|--|--|
| Temperature Monitor Using Analog Pad AT | | | | | | | | | | | |
| External | Resolution | 8-bit ADC | | °C | | | | | | | |
| Temperature | | 10-bit ADC | | 1 | | | | | | | |
| (external diode | | 12-bit ADC | | C |).25 | °C | | | | | |
| 2N3904, T _J = 25°C) ⁴ | Systematic Offset ⁵ | AFS090, AFS250, AFS600, AFS1500, uncalibrated ⁷ | | 5 | | | | | | | |
| | | AFS090, AFS250, AFS600, AFS1500, calibrated ⁷ | | ±5 | | | | | | | |
| | Accuracy | | | ±3 | ±5 | °C | | | | | |
| | External Sensor Source | High level, TMSTBx = 0 | | 10 | | μA | | | | | |
| | Current | Low level, TMSTBx = 1 | | 100 | | μA | | | | | |
| | Max Capacitance on AT pad | | | | 1.3 | nF | | | | | |
| Internal | Resolution | 8-bit ADC | 4 | | | °C | | | | | |
| Temperature | | 10-bit ADC | 1 | | | °C | | | | | |
| Mornton | | 12-bit ADC | 0.25 | | | °C | | | | | |
| | Systematic Offset ⁵ | AFS090 ⁷ | | | 5 | °C | | | | | |
| | | AFS250, AFS600, AFS1500 ⁷ | | | 11 | °C | | | | | |
| | Accuracy | | | ±3 | ±5 | °C | | | | | |
| t _{TMSHI} | Strobe High time | | 10 | | 105 | μs | | | | | |
| t _{TMSLO} | Strobe Low time | | 5 | | | μs | | | | | |
| t _{TMSSET} | Settling time | | 5 | | | μs | | | | | |

Notes:

1. VRSM is the maximum voltage drop across the current sense resistor.

2. Analog inputs used as digital inputs can tolerate the same voltage limits as the corresponding analog pad. There is no reliability concern on digital inputs as long as VIND does not exceed these limits.

3. VIND is limited to VCC33A + 0.2 to allow reaching 10 MHz input frequency.

- 4. An averaging of 1,024 samples (LPF setting in Analog System Builder) is required and the maximum capacitance allowed across the AT pins is 500 pF.
- 5. The temperature offset is a fixed positive value.
- 6. The high current mode has a maximum power limit of 20 mW. Appropriate current limit resistors must be used, based on voltage on the pad.
- 7. When using SmartGen Analog System Builder, CalibIP is required to obtain specified offset. For further details on CalibIP, refer to the "Temperature, Voltage, and Current Calibration in Fusion FPGAs" chapter of the Fusion FPGA Fabric User Guide.

Table 2-57 details the settings available to control the prescaler values of the AV, AC, and AT pins. Note that the AT pin has a reduced number of available prescaler values.

| Control Lines Bx[2:0] | Scaling Factor, Pad to ADC Input | LSB for an 8-Bit Conversion ¹ (mV) | LSB for a 10-Bit Conversion ¹ (mV) | LSB for a 12-Bit Conversion ¹ (mV) | Full-Scale Voltage in 10-Bit Mode ² | Range Name |
|--------------------------|--|--|--|--|---|------------|
| 000 ³ | 0.15625 | 64 | 16 | 4 | 16.368 V | 16 V |
| 001 | 0.3125 | 32 | 8 | 2 | 8.184 V | 8 V |
| 010 ³ | 0.625 | 16 | 4 | 1 | 4.092 V | 4 V |
| 011 | 1.25 | 8 | 2 | 0.5 | 2.046 V | 2 V |
| 100 | 2.5 | 4 | 1 | 0.25 | 1.023 V | 1 V |
| 101 | 5.0 | 2 | 0.5 | 0.125 | 0.5115 V | 0.5 V |
| 110 | 10.0 | 1 | 0.25 | 0.0625 | 0.25575 V | 0.25 V |
| 111 | 20.0 | 0.5 | 0.125 | 0.03125 | 0.127875 V | 0.125 V |

Table 2-57 • Prescaler Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)

Notes:

1. LSB voltage equivalences assume VAREF = 2.56 V.

2. Full Scale voltage for n-bit mode: ((2ⁿ) - 1) x (LSB for a n-bit Conversion)

3. These are the only valid ranges for the Temperature Monitor Block Prescaler.

Table 2-58 details the settings available to control the MUX within each of the AV, AC, and AT circuits. This MUX determines whether the signal routed to the ADC is the direct analog input, prescaled signal, or output of either the Current Monitor Block or the Temperature Monitor Block.

Table 2-58 • Analog Multiplexer Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)

| Control Lines Bx[4] | Control Lines Bx[3] | ADC Connected To |
|---------------------|---------------------|---------------------------------------|
| 0 | 0 | Prescaler |
| 0 | 1 | Direct input |
| 1 | 0 | Current amplifier temperature monitor |
| 1 | 1 | Not valid |

Table 2-59 details the settings available to control the Direct Analog Input switch for the AV, AC, and AT pins.

Table 2-59 • Direct Analog Input Switch Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)

| Control Lines Bx[5] | Direct Input Switch |
|---------------------|---------------------|
| 0 | Off |
| 1 | On |

Table 2-60 details the settings available to control the polarity of the signals coming to the AV, AC, and AT pins. Note that the only valid setting for the AT pin is logic 0 to support positive voltages.

Table 2-60 • Voltage Polarity Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)*

| Control Lines Bx[6] | Input Signal Polarity |
|---------------------|-----------------------|
| 0 | Positive |
| 1 | Negative |

Note: *The B3[6] signal for the AT pad should be kept at logic 0 to accept only positive voltages.

I/O Registers

Each I/O module contains several input, output, and enable registers. Refer to Figure 2-100 for a simplified representation of the I/O block.

The number of input registers is selected by a set of switches (not shown in Figure 2-100) between registers to implement single or differential data transmission to and from the FPGA core. The Designer software sets these switches for the user.

A common CLR/PRE signal is employed by all I/O registers when I/O register combining is used. Input register 2 does not have a CLR/PRE pin, as this register is used for DDR implementation. The I/O register combining must satisfy some rules.



Note: Fusion I/Os have registers to support DDR functionality (see the "Double Data Rate (DDR) Support" section on page 2-139 for more information).

Figure 2-100 • I/O Block Logical Representation



Device Architecture

| I/O Standard | Input/Output Supply Voltage (VCCI_TYP) | Input Reference Voltage (VREF_TYP) | Board Termination Voltage (VTT_TYP) |
|-------------------------------|---|---------------------------------------|--|
| LVTTL/LVCMOS 3.3 V | 3.30 V | - | - |
| LVCMOS 2.5 V | 2.50 V | - | - |
| LVCMOS 2.5 V / 5.0 V Input | 2.50 V | - | - |
| LVCMOS 1.8 V | 1.80 V | - | - |
| LVCMOS 1.5 V | 1.50 V | - | - |
| PCI 3.3 V | 3.30 V | - | - |
| PCI-X 3.3 V | 3.30 V | - | - |
| GTL+ 3.3 V | 3.30 V | 1.00 V | 1.50 V |
| GTL+ 2.5 V | 2.50 V | 1.00 V | 1.50 V |
| GTL 3.3 V | 3.30 V | 0.80 V | 1.20 V |
| GTL 2.5 V | 2.50 V | 0.80 V | 1.20 V |
| HSTL Class I | 1.50 V | 0.75 V | 0.75 V |
| HSTL Class II | 1.50 V | 0.75 V | 0.75 V |
| SSTL3 Class I | 3.30 V | 1.50 V | 1.50 V |
| SSTL3 Class II | 3.30 V | 1.50 V | 1.50 V |
| SSTL2 Class I | 2.50 V | 1.25 V | 1.25 V |
| SSTL2 Class II | 2.50 V | 1.25 V | 1.25 V |
| LVDS, BLVDS, M-LVDS | 2.50 V | - | - |
| LVPECL | 3.30 V | _ | - |

Table 2-83 • Fusion Pro I/O Supported Standards and Corresponding VREF and VTT Voltages

Table 2-93 • Summary of I/O Timing Characteristics – Software Default SettingsCommercial Temperature Range Conditions: TJ = 70°C, Worst-Case VCC = 1.425 V,Worst-Case VCCI = I/O Standard DependentApplicable to Advanced I/Os

| I/O Standard | Drive Strength (mA) | Slew Rate | Capacitive Load (pF) | External Resistor (Ohm) | tpour | top | toin | tey | teout | tzı | tzH | t _{LZ} | tHZ | tzıs | tzHS | Units |
|------------------------------|---------------------|-----------|----------------------|-------------------------|-------|------|------|------|-------|------|------|-----------------|------|------|------|-------|
| 3.3 V LVTTL/ 3.3 V LVCMOS | 12 mA | High | 35 pF | - | 0.49 | 2.64 | 0.03 | 0.90 | 0.32 | 2.69 | 2.11 | 2.40 | 2.68 | 4.36 | 3.78 | ns |
| 2.5 V LVCMOS | 12 mA | High | 35 pF | _ | 0.49 | 2.66 | 0.03 | 0.98 | 0.32 | 2.71 | 2.56 | 2.47 | 2.57 | 4.38 | 4.23 | ns |
| 1.8 V LVCMOS | 12 mA | High | 35 pF | _ | 0.49 | 2.64 | 0.03 | 0.91 | 0.32 | 2.69 | 2.27 | 2.76 | 3.05 | 4.36 | 3.94 | ns |
| 1.5 V LVCMOS | 12 mA | High | 35 pF | _ | 0.49 | 3.05 | 0.03 | 1.07 | 0.32 | 3.10 | 2.67 | 2.95 | 3.14 | 4.77 | 4.34 | ns |
| 3.3 V PCI | Per PCI spec | High | 10 pF | 25 ² | 0.49 | 2.00 | 0.03 | 0.65 | 0.32 | 2.04 | 1.46 | 2.40 | 2.68 | 3.71 | 3.13 | ns |
| 3.3 V PCI-X | Per PCI-X spec | High | 10 pF | 25 ² | 0.49 | 2.00 | 0.03 | 0.62 | 0.32 | 2.04 | 1.46 | 2.40 | 2.68 | 3.71 | 3.13 | ns |
| LVDS | 24 mA | High | _ | - | 0.49 | 1.37 | 0.03 | 1.20 | N/A | N/A | N/A | N/A | N/A | N/A | N/A | ns |
| LVPECL | 24 mA | High | - | _ | 0.49 | 1.34 | 0.03 | 1.05 | N/A | N/A | N/A | N/A | N/A | N/A | N/A | ns |

Notes:

1. For specific junction temperature and voltage-supply levels, refer to Table 3-6 on page 3-7 for derating values.

2. Resistance is used to measure I/O propagation delays as defined in PCI specifications. See Figure 2-123 on page 2-197 for connectivity. This resistor is not required during normal operation.

Table 2-94 • Summary of I/O Timing Characteristics – Software Default SettingsCommercial Temperature Range Conditions: TJ = 70°C, Worst-Case VCC = 1.425 V,Worst-Case VCCI = I/O Standard DependentApplicable to Standard I/Os

| I/O Standard | Drive Strength (mA) | Slew Rate | Capacitive Load (pF) | External Resistor (Ohm) | t pour | t _{DP} | t _{DIN} | t _Þ v | teour | tzı | tzH | t _{LZ} | t _{HZ} | Units |
|------------------------------|---------------------|-----------|----------------------|-------------------------|--------|-----------------|------------------|------------------|-------|------|------|-----------------|-----------------|-------|
| 3.3 V LVTTL/ 3.3 V LVCMOS | 8 mA | High | 35 pF | - | 0.49 | 3.29 | 0.03 | 0.75 | 0.32 | 3.36 | 2.80 | 1.79 | 2.01 | ns |
| 2.5 V LVCMOS | 8 mA | High | 35pF | - | 0.49 | 3.56 | 0.03 | 0.96 | 0.32 | 3.40 | 3.56 | 1.78 | 1.91 | ns |
| 1.8 V LVCMOS | 4 mA | High | 35pF | _ | 0.49 | 4.74 | 0.03 | 0.90 | 0.32 | 4.02 | 4.74 | 1.80 | 1.85 | ns |
| 1.5 V LVCMOS | 2 mA | High | 35pF | — | 0.49 | 5.71 | 0.03 | 1.06 | 0.32 | 4.71 | 5.71 | 1.83 | 1.83 | ns |

Note: For specific junction temperature and voltage-supply levels, refer to Table 3-6 on page 3-7 for derating values.

Table 2-132 • 1.5 V LVCMOS Low Slew
Commercial Temperature Range Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V,
Worst-Case VCCI = 1.4 V
Applicable to Standard I/Os

| Drive Strength | Speed Grade | t _{DOUT} | t _{DP} | t _{DIN} | t _{PY} | t _{EOUT} | t _{ZL} | t _{zH} | t _{LZ} | t _{HZ} | Units |
|-------------------|----------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|-------|
| 2 mA | Std. | 0.66 | 12.33 | 0.04 | 1.42 | 0.43 | 11.79 | 12.33 | 2.45 | 2.32 | ns |
| | -1 | 0.56 | 10.49 | 0.04 | 1.21 | 0.36 | 10.03 | 10.49 | 2.08 | 1.98 | ns |
| | -2 | 0.49 | 9.21 | 0.03 | 1.06 | 0.32 | 8.81 | 9.21 | 1.83 | 1.73 | ns |

Note: For the derating values at specific junction temperature and voltage supply levels, refer to Table 3-7 on page 3-9.

Table 2-133 • 1.5 V LVCMOS High Slew

Commercial Temperature Range Conditions: $T_J = 70^{\circ}$ C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.4 V Applicable to Standard I/Os

| Drive Strength | Speed Grade | t _{DOUT} | t _{DP} | t _{DIN} | t _{PY} | t _{EOUT} | t _{ZL} | t _{ZH} | t _{LZ} | t _{HZ} | Units |
|-------------------|----------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|-------|
| 2 mA | Std. | 0.66 | 7.65 | 0.04 | 1.42 | 0.43 | 6.31 | 7.65 | 2.45 | 2.45 | ns |
| | -1 | 0.56 | 6.50 | 0.04 | 1.21 | 0.36 | 5.37 | 6.50 | 2.08 | 2.08 | ns |
| | -2 | 0.49 | 5.71 | 0.03 | 1.06 | 0.32 | 4.71 | 5.71 | 1.83 | 1.83 | ns |

Note: For the derating values at specific junction temperature and voltage supply levels, refer to Table 3-7 on page 3-9.



DC and Power Characteristics

| Parameter | Description | Conditions | Temp. | Min | Тур | Мах | Unit |
|-----------|-----------------------------|--|------------------------|-----|-----|-----|------|
| ICCNVM | Embedded NVM current | Reset asserted, VCCNVM = 1.575 V | T _J = 25°C | | 10 | 40 | μA |
| | | | T _J = 85°C | | 14 | 40 | μA |
| | | | T _J = 100°C | | 14 | 40 | μA |
| ICCPLL | 1.5 V PLL quiescent current | Operational standby, VCCPLL = 1.575 V | T _J = 25°C | | 65 | 100 | μA |
| | | | T _J = 85°C | | 65 | 100 | μA |
| | | | T _J = 100°C | | 65 | 100 | μA |

Table 3-11 • AFS090 Quiescent Supply Current Characteristics (continued)

Notes:

1. ICC is the 1.5 V power supplies, ICC, ICCPLL, ICC15A, ICCNVM.

2. ICC33A includes ICC33A, ICC33PMP, and ICCOSC.

- 3. ICCI includes all ICCI0, ICCI1, and ICCI2.
- 4. Operational standby is when the Fusion device is powered up, all blocks are used, no I/O is toggling, Voltage Regulator is loaded with 200 mA, VCC33PMP is ON, XTAL is ON, and ADC is ON.

5. XTAL is configured as high gain, VCC = VJTAG = VPUMP = 0 V.

6. Sleep Mode, VCC = VJTAG = VPUMP = 0 V.

| FG256 | | | | | | | |
|------------|-----------------|-----------------|-----------------|------------------|--|--|--|
| Pin Number | AFS090 Function | AFS250 Function | AFS600 Function | AFS1500 Function | | | |
| R5 | AV0 | AV0 | AV2 | AV2 | | | |
| R6 | AT0 | AT0 | AT2 | AT2 | | | |
| R7 | AV1 | AV1 | AV3 | AV3 | | | |
| R8 | AT3 | AT3 | AT5 | AT5 | | | |
| R9 | AV4 | AV4 | AV6 | AV6 | | | |
| R10 | NC | AT5 | AT7 | AT7 | | | |
| R11 | NC | AV5 | AV7 | AV7 | | | |
| R12 | NC | NC | AT9 | AT9 | | | |
| R13 | NC | NC | AG9 | AG9 | | | |
| R14 | NC | NC | AC9 | AC9 | | | |
| R15 | PUB | PUB | PUB | PUB | | | |
| R16 | VCCIB1 | VCCIB1 | VCCIB2 | VCCIB2 | | | |
| T1 | GND | GND | GND | GND | | | |
| T2 | NCAP | NCAP | NCAP | NCAP | | | |
| Т3 | VCC33N | VCC33N | VCC33N | VCC33N | | | |
| T4 | NC | NC | ATRTN0 | ATRTN0 | | | |
| T5 | AT1 | AT1 | AT3 | AT3 | | | |
| Т6 | ATRTN0 | ATRTN0 | ATRTN1 | ATRTN1 | | | |
| Τ7 | AT2 | AT2 | AT4 | AT4 | | | |
| Т8 | ATRTN1 | ATRTN1 | ATRTN2 | ATRTN2 | | | |
| Т9 | AT4 | AT4 | AT6 | AT6 | | | |
| T10 | ATRTN2 | ATRTN2 | ATRTN3 | ATRTN3 | | | |
| T11 | NC | NC | AT8 | AT8 | | | |
| T12 | NC | NC | ATRTN4 | ATRTN4 | | | |
| T13 | GNDA | GNDA | GNDA | GNDA | | | |
| T14 | VCC33A | VCC33A | VCC33A | VCC33A | | | |
| T15 | VAREF | VAREF | VAREF | VAREF | | | |
| T16 | GND | GND | GND | GND | | | |



FG484



Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/default.aspx.